

Notice of References Cited	Application/Control No. 10/583,142		Applicant(s)/Patent Under Reexamination IZUMINO ET AL.	
	Examiner ENRIQUE W. ITURRALDE		Art Unit 2179	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0189589	10-2003	LeBlanc et al.	345/723
*	B	US-2002/0065741	05-2002	Baum, Daniel R.	705/26
*	C	US-6,657,702	12-2003	Chui et al.	355/40
*	D	US-2002/0001102	01-2002	Williams, Eddie H.	358/1.18
*	E	US-2002/0138843	09-2002	Samaan et al.	725/87
*	F	US-2002/0024590	02-2002	Pena, Martin Rangel	348/14.08
*	G	US-2002/0138843	09-2002	Samaan et al.	725/87
*	H	US-2002/0135794	09-2002	Rodriguez et al.	358/1.15
*	I	US-2003/0021591	01-2003	Grosvenor et al.	386/124
*	J	US-6,795,863	09-2004	Doty, Jr., Thomas R.	709/231
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP2001054046	02-2001	Japan		
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.